

<b>Notice of References Cited</b>	Application/Control No. 10/036,637	Applicant(s)/Patent Under Reexamination BIYIKLI, LEVENT	
	Examiner Patrick J. Lee	Art Unit 2878	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	K	US-			
	L	US-			
	M	US-			

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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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